

DC Area FIB/SEM UGM

Thursday, February 7, 2008
1:30 PM to 4:30 PM

Bldg 215, Rm C103-C106
National Institute of Standards and Technology

- 1:30 Welcome: Gerard Henein, Keana Scott
- 1:40 Rhonda Stroud, NRL
- 2:00 David MacMahon, Micron
- 2:20 Coffee Break
- 2:40 Henri Lezec, NIST
- 3:20 David Elbert, Johns Hopkins University
Joanne Stubbs, Johns Hopkins Univeristy
Brian Schuster, Army Research Laboratory
- 3:50 Open Discussion: Organizational Details
- 4:20 Wrap-up: Nabil Bassim

NIST Contact:

Keana Scott, x4579

Sponsors:

NIST CSTL Microanalysis Research Group
NIST CNST NanoFab User Group
FEI Company

